

- Automated testing of SMD oscillators held in two flip pallets
- Uses S&A 280B Oscillator Analyzer for fast and accurate oscillator measurements
- Over 25 different oscillator parameters can be measured including waveform, linearity, and start up time
- Failures are binned into 1 of 5 bins
- Generates and prints statistical and distribution data using *Crystal Reports*®
- Dual pallet tables for easy pallet removal while running or for orientation (optional)
- Optional Oscilloscope



SPECIFICATIONS

Typical Throughput:	2 seconds per part
280B Frequency Range:	10 KHz to 1 GHz
Oscilloscope Analog Bandwidth:	600 MHz (rise time 1% error at 5 nsec)
Oscillator X10 Probe Bandwidth:	1 KHz to 850 MHz (2.5 K Ohm Max Impedance)
Oscillator X50 Probe Bandwidth:	1 KHz to 500 MHz (12.5 K Ohm Max Impedance)